## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | CHAPPIDI ET AL. | Examiner | Daniel I Walsh | Page 1 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-2004/0155778	08-2004	Shek et al.	340/572.1
	В	US-2004/0108954	06-2004	Richley et al.	342/387
	С	US-6,380,894	04-2002	Boyd et al.	342/450
	D	US-5,959,568	09-1999	Woolley, Louis A.	342/42
	Е	US-5,804,810	09-1998	Woolley et al.	235/492
	F	US-5,119,104	06-1992	Heller, Alan C.	342/450
	G	US-2002/0167417	11-2002	Welles et al.	340/825.49
	н	US-2002/0125996	09-2002	Feinberg, Paul H.	340/10.41
	1	US-2002/0032525	03-2002	Yoshikawa et al.	701/213
	J	US-2001/0030625	10-2001	Doles et al.	342/387
	к	US-6,738,628	05-2004	McCall et al.	455/456.1
	L	US-6,720,876	04-2004	Burgess, David A.	340/568.1
	м	US-6,480,787	11-2002	Yoshikawa et al.	701/213

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
<u>'</u>	N	WO 2091297 A1	11-2002	USA	Wildman	
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

### Notice of References Cited Application/Control No. 10/708,902 Examiner Daniel I Walsh Applicant(s)/Patent Under Reexamination CHAPPIDI ET AL. Page 2 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0234741	12-2003	Rogers et al.	342/463
	В	US-2003/0191767	10-2003	Kabala, Stanley J.	707/100
	С	US-2003/0030568	02-2003	Lastinger et al.	340/825.49
	D	US-2002/0183979	12-2002	Wildman, Timothy D.	702/188
	E	US-6,556,942	04-2003	Smith, Stephen F.	702/150
	F	US-6,539,393	03-2003	Kabala, Stanley J.	707/102
	G.	US-6,121,926	09-2000	Belcher et al.	342/450
	Н	US-2004/0189471	09-2004	Ciarcia et al.	340/572.1
	1	US-2004/0174264	09-2004	Reisman et al.	340/573.4
	J	US-2004/0104817	06-2004	Wijk, Wouter Uco van	340/505
	к	US-2004/0021566	02-2004	Hayashi et al.	340/539.13
	L	US-6,727,818	04-2004	Wildman et al.	340/573.1
	М	US-2003/0137968	07-2003	Lareau et al.	370/349

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
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### **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 10/708,902 Examiner Daniel I Walsh Applicant(s)/Patent Under Reexamination CHAPPIDI ET AL. Page 3 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0174260	09-2004	Wagner, Ronald E.	340/568.1
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
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	н	US-			
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	J	US-			
	К	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.